



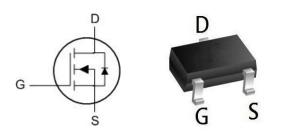
Product data sheet

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SOT23 Pin Configuration



Product Summary

BVDSS	RDSON	ID
100V	105 mΩ	3A

★ Green Device Available

★ Super Low Gate Charge

★ Excellent Cdv/dt effect decline

★ Advanced high cell density Trench technology

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	V _{DS} Drain-Source Voltage		V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	3	A
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	2.2	А
IDM	Pulsed Drain Current ²	11	A
PD@TA=25°C	Total Power Dissipation ³	1	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-ambient ¹		125	°C/W
Rejc	Thermal Resistance Junction-Case ¹		80	°C/W





Electrical Characteristics Tc=25°C unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Chara	cteristic	1		•		
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250µA	100	110	-	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 100V, V _{GS} = 0V	-	-	1	μA
lgss	Gate to Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	cteristics note3					
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250µA	1.0	1.95	3.0	V
R _{DS(on)}	Static Drain-Source On-Resistance note2	V _{GS} = 10V, I _D = 3A	-	105	140	mΩ
Dynamic (Characteristics ^{note4}	1	I	1	I	
Ciss	Input Capacitance		-	196	-	pF
Coss	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V,$	-	25.9	-	pF
Crss	Reverse Transfer Capacitance	f = 1.0MHz	-	21.4	-	pF
Qg	Total Gate Charge		-	4.3	-	nC
Q _{gs}	Gate-Source Charge	$V_{DS} = 50V, I_D = 3A,$	-	3.5	-	nC
Q _{gd}	Gate-Drain("Miller") Charge	V _{GS} = 10V	-	3.1	-	nC
Switching	Characteristics ^{note4}					
t _{d(on)}	Turn-On Delay Time		-	14.7	-	ns
tr	Turn-On Rise Time	$V_{DD} = 50V, I_{DS} = 3A$	-	3.5	-	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 2\Omega$, $V_{GEN} = 10V$	-	20.9	-	ns
t _f	Turn-Off Fall Time		-	2.7	-	ns
Drain-Sou	irce Diode Characteristics and Maximum Rati	ngs		•		
ls	Maximum Continuous Drain to Source Diode Forward Current note2		-	-	4.5	А
lsм	Maximum Pulsed Drain to Source Diode Forward Current		-	-	12	А
V _{SD}	Drain to Source Diode Forward Voltage note3	V _{GS} = 0V, I _S =3A	-	-	1.3	V
trr	Body Diode Reverse Recovery Time		-	32.1	-	ns
Qrr	Body Diode Reverse Recovery Time Charge	$V_{GS} = 0V, I_F = 3A,$	-	39.4	-	nC
Irrm	Peak Reverse Recovery Current	− di/dt =100A/µs	-	2.1	-	А

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. Surface Mounted on FR4 Board, t \leq 10 sec.

3. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.

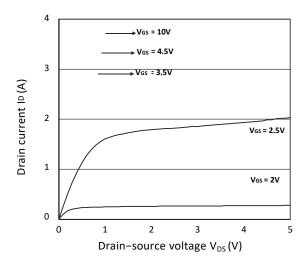
4. Guaranteed by design, not subject to production

5. V_DD=50 V, RG=50 Ω , L=0.3 mH, starting Tj=25 °C

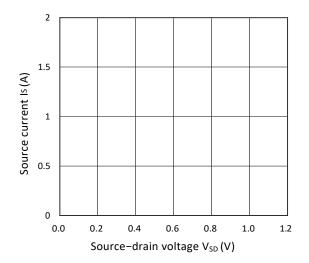




Typical Characteristics









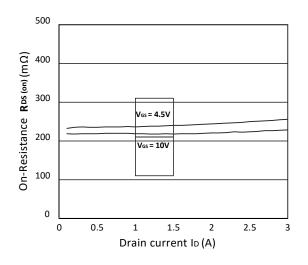


Figure 5. R_{DS(ON)} vs. I_D

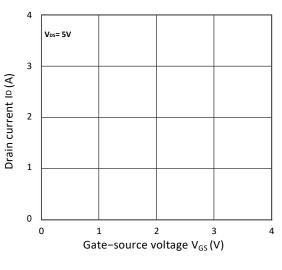
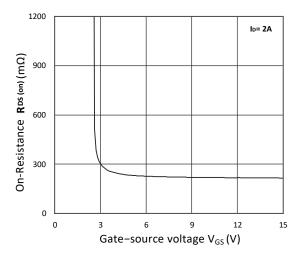
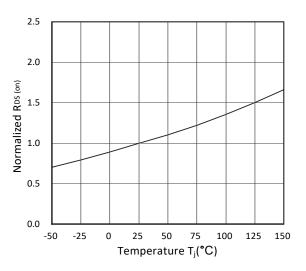


Figure 2. Transfer Characteristics



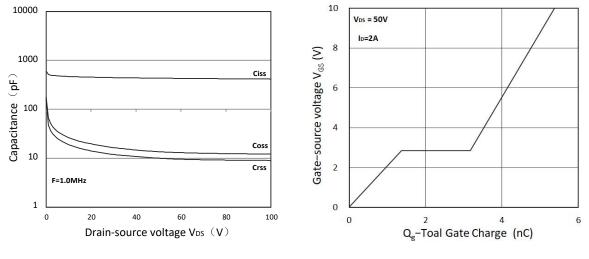












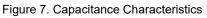
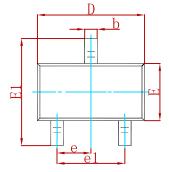


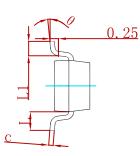
Figure 8. Gate Charge Characteristics

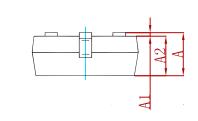




PACKAGE MECHANICAL DATA

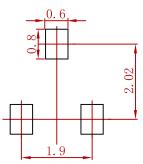






Symbol	Dimensions In Millimeters		Dimensions In Inches	
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950 TYP		0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
5N10	SOT-23	3000



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